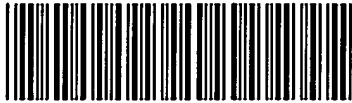


Search Notes

Application/Control No.

09/916,511

Examiner

EDMUND H. LEE

Applicant(s)/Patent under
Reexamination

TANAKA ET AL.

Art Unit

1732

SEARCHED

Class	Subclass	Date	Examiner
UPDATED		5/25/2005	EHL

INTERFERENCE SEARCHED

Class	Subclass	Date	Examiner
264	248,250	5/25/2005	EHL
	255		
	279.1		

**SEARCH NOTES
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR